Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L13	2	(("6632724") or ("6013563")).PN.	US-PGPUB; USPAT	OR	OFF	2006/01/10 10:30
L14	4	(("5993677") or ("5804086") or ("5714395") or ("5374564")).PN.	US-PGPUB; USPAT	OR	OFF	2006/01/10 10:25
L15	27128	(cleav\$3 same (wafer or substrate))	US-PGPUB; USPAT	OR	ON	2006/01/10 10:53
L16	10287	15 and energy	US-PGPUB; USPAT	OR	ON	2006/01/10 10:43
L18	9555	16 and (separat\$3 or detach\$4 or removing)	US-PGPUB; USPAT	OR	ON	2006/01/10 10:33
L20	6166	18 and releas\$3	US-PGPUB; USPAT	OR	ON	2006/01/10 10:33
L21	1562	18 and (releas\$3 with (wafer or substrate))	US-PGPUB; USPAT	OR	ON	2006/01/10 10:34
L22	1400	21 and transfer\$4	US-PGPUB; USPAT	OR	ON	2006/01/10 10:35
L23	389	22 and (energy same (cleav\$3))	US-PGPUB; USPAT	OR	ON	2006/01/10 10:38
L24	45	23 and @ad<"19970512"	US-PGPUB; USPAT	OR	ON	2006/01/10 10:52
L25	47	((francois near3 henley) or (nathan near3 cheung)) and @ad<"19970512"	US-PGPUB; USPAT	OR	ON	2006/01/10 10:42
L26	4025	(cleav\$3 same (wafer or substrate))	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/10 10:43
L28	184	26 and (energy same cleav\$3)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/01/10 10:52
L29	3153	438/455,528,458,459,526,974.ccls.	US-PGPUB; USPAT	OR	ON	2006/01/10 10:52
L30	924	29 and @ad<"19970512"	US-PGPUB; USPAT	OR	ON	2006/01/10 10:53
L31	2	(cleav\$3 and (wafer or substrate or workpiece) and energy and (film or layer) and transferring and (releasing or detaching or detachment or separating or separation or separated)).clm.	US-PGPUB; USPAT	OR	ON	2006/01/10 10:55

US-PAT-NO:

5863830

DOCUMENT-IDENTIFIER: US 5863830 A

TITLE:

Process for the production of a structure having a thin

semiconductor film on a substrate

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Claims Text - CLTX (1):

1. A process for the production of a structure having a semiconductor thin **film** (4) adhering to a target **substrate** (24), comprising the following steps:

Claims Text - CLTX (2):

a) producing a first structure having a thin semiconductor <u>film</u> on a first <u>substrate</u> (2) to form a thin <u>film</u>-first <u>substrate</u> assembly, the thin <u>film</u> having a first free face (10) called the front face and a second face (8) called the rear face bonded to the first <u>substrate</u> by a first bonding <u>energy</u> E.sub.0, and

Claims Text - CLTX (3):

b) <u>transferring</u> the thin <u>film</u> (4) from the first <u>substrate</u> (2) to the target <u>substrate</u> (24), said transfer involving both a tearing of the thin <u>film</u> (4) from the first <u>substrate</u> (2) by application to the thin <u>film</u>-first <u>substrate</u> assembly tearing away forces able to overcome the first bonding <u>energy</u> and adhesive contacting of the thin <u>film</u> (4) with the target <u>substrate</u> (24), said <u>transferring</u> being accomplished by

Claims Text - CLTX (4):

b.sub.1) the adhesive contacting of a manipulator (12) with the first face (10) of the thin <u>film</u> (4), the adhesive contact being established with a second bonding <u>energy</u> E.sub.1 exceeding the first bonding <u>energy</u>,

Claims Text - CLTX (5):

b.sub.2) <u>separating</u> of the thin <u>film</u> (4) and the first <u>substrate</u> (2) by tearing away the thin <u>film</u> (4) level with the second face (8) and the first <u>substrate</u>, and

Claims Text - CLTX (6):

b.sub.3) adhesive contacting of the second face of the thin film (4) with

the target <u>substrate</u> (24) with a third bonding <u>energy</u> E.sub.2 and <u>separating</u> of the thin <u>film</u> (4) from the manipulator (12).

Claims Text - CLTX (7):

2. The process according to claim 1, characterized in that the third bonding <u>energy</u> E.sub.2 exceeds the second bonding <u>energy</u> E.sub.1.

Claims Text - CLTX (8):

3. The process according to claim 1, characterized in that the first substrate (2) has an expansion coefficient substantially identical to the expansion coefficient of the thin <u>film</u>.

Claims Text - CLTX (10):

5. The process according to claim 1, characterized in that the thin <u>film</u> on the first <u>substrate</u> is obtained by:

Claims Text - CLTX (11):

an implantation of ions of rare gas or hydrogen in a supplementary <u>substrate</u> through its surface so as to generate a <u>layer</u> of gaseous microbubbles extending substantially in accordance with a plane defining in the supplementary <u>substrate</u> a surface thin <u>film</u>,

Claims Text - CLTX (12):

the adhesive contacting of the thin <u>film</u> and the first <u>substrate</u> with the first bonding energy, and

Claims Text - CLTX (13):

a heat treatment, which by a crystalline rearrangement effect and by a pressure effect in the gaseous microbubbles brings about a <u>cleaving separating</u> the film from the remainder of the supplementary <u>substrate</u>.

Claims Text - CLTX (14):

6. The process according to claim 1, characterized in that during step b.sub.3), the <u>separation</u> of the thin <u>film</u> (4) and the manipulator takes place after the adhesive contacting of the <u>film</u> (4) with the target <u>substrate</u> (24).

Claims Text - CLTX (15):

7. The process according to claim 1, characterized in that during step b.sub.3), the <u>separation</u> of the thin <u>film</u> (4) and the manipulator takes place prior to the adhesive contacting of the <u>film</u> (4) and the target <u>substrate</u> (24).

Claims Text - CLTX (16):

8. The process according to claim 7, characterized in that during step b.sub.3), the manipulator and thin <u>film</u> are immersed in a chemical bath to dissolve the manipulator, the <u>film</u> being collected on the target <u>substrate</u>.

Claims Text - CLTX (17):

9. The process according to claim 7, characterized in that during step b.sub.3), the thin <u>film</u> (4) is adhesively contacted with the target <u>substrate</u> (24) by its first or second face.

Claims Text - CLTX (18):

10. The process according to claim 1, characterized in that during step b.sub.1), the adhesive contacting between the manipulator (12) and the thin **film** (4) is brought about by electrostatic forces and during step b.sub.3), the **separation of the film** (4) and the manipulator (12) is obtained by eliminating said electrostatic forces.

Claims Text - CLTX (20):

12. The process according to claim 1, characterized in that the adhesive contact between the thin <u>film</u> and the manipulator is brought about with an adhesive.

Claims Text - CLTX (21):

13. The process according to claim 1, characterized in that the target **substrate** has a contacting surface above the surface of one of the first and second faces of the thin **film**.

Claims Text - CLTX (22):

14. The process according to claim 1, characterized in that the thin <u>film</u>(4) is a monocrystalline, semiconductor material <u>film</u>.